

#### **FEATURES AND BENEFITS**

- Patented integrated digital temperature compensation circuitry allows for near closed loop accuracy over temperature in an open loop sensor
- UL60950-1 (ed. 2) certified
   □ Dielectric Strength Voltage = 2.4 kVrms
   □ Basic Isolation Working Voltage = 420 Vpk/297
- Industry-leading noise performance with greatly improved bandwidth through proprietary amplifier and filter design techniques
- Pin-selectable band width: 80 kHz for high bandwidth applications or 20 kHz for low noise performance.
- $0.65 \text{ m}\Omega$  primary conductor resistance for low power loss and high inrush current withstand capability
- Small footprint, low-profile SOIC8 package suitable for space-constrained applications
- Integrated shield virtually eliminates capacitive coupling from current conductor to die, greatly suppressing output noise due to high dv/dt transients
- 3 to 3.6 V, single supply operation

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#### Package: 8-pin SOIC (suffix LC)



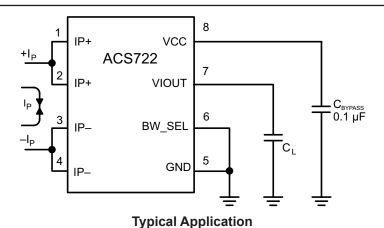
#### DESCRIPTION

The Allegro™ ACS722 current sensor IC is an economical and precise solution for AC or DC current sensing in industrial, commercial, and communications systems. The small package is ideal for space constrained applications while also saving costs due to reduced board area. Typical applications include motor control, load detection and management, switched-mode power supplies, and overcurrent fault protection.

The device consists of a precise, low-offset, linear Hall sensor circuit with a copper conduction path located near the surface of the die. Applied current flowing through this copper conduction path generates a magnetic field which is sensed by the integrated Hall IC and converted into a proportional voltage. Device accuracy is optimized through the close proximity of the magnetic field to the Hall transducer. A precise, proportional voltage is provided by the low-offset, chopper-stabilized BiCMOS Hall IC, which includes Allegro's patented digital temperature compensation, resulting in extremely accurate performance over temperature. The output of the device has a positive slope when an increasing current flows through the primary copper conduction path (from pins 1 and 2, to pins 3 and 4), which is the path used for current sensing. The internal resistance of this conductive path is  $0.65 \,\mathrm{m}\Omega$  typical, providing low power loss.

The terminals of the conductive path are electrically isolated from the sensor leads (pins 5 through 8). This allows the ACS722 current sensor IC to be used in high-side current sense applications without the use of high-side differential amplifiers or other costly isolation techniques.

The ACS722 is provided in a small, low profile surface mount SOIC8 package. The leadframe is plated with 100% matte tin, *Continued on the next page*...



The ACS722 outputs an analog signal, V<sub>IOUT</sub>, that changes, proportionally, with the bidirectional AC or DC primary sensed current, I<sub>P</sub>, within the specified measurement range. The BW\_SEL pin can be used to select one of the two bandwidths to optimize the noise performance.

## High Accuracy, Galvanically Isolated Current Sensor IC With Small Footprint SOIC8 Package

#### Features and Benefits (continued)

- Output voltage proportional to AC or DC current
- Factory-trimmed sensitivity and quiescent output voltage for improved accuracy
- Chopper stabilization results in extremely stable quiescent output voltage
- Nearly zero magnetic hysteresis
- Ratiometric output from supply voltage

### Description (continued)

which is compatible with standard lead (Pb) free printed circuit board assembly processes. Internally, the device is Pb-free, except for flip-chip high-temperature Pb-based solder balls, currently exempt from RoHS. The device is fully calibrated prior to shipment from the factory.

#### **Selection Guide**

Part Number	I <sub>PR</sub> (A)	Sens(Typ) at V <sub>CC</sub> = 3.3 V (mV/A)	T <sub>A</sub> (°C)	Packing <sup>1</sup>
ACS722LLCTR-05AB-T <sup>2</sup>	±5	264		
ACS722LLCTR-10AU-T <sup>2</sup>	10	204		
ACS722LLCTR-10AB-T <sup>2</sup>	±10	132	-40 to 150	
ACS722LLCTR-20AU-T <sup>2</sup>	20	132		Tape and Reel, 3000 pieces per reel
ACS722LLCTR-20AB-T <sup>2</sup>	±20	66		
ACS722LLCTR-40AU-T <sup>2</sup>	40	00		
ACS722LLCTR-40AB-T <sup>2</sup>	±40	33		

<sup>&</sup>lt;sup>1</sup>Contact Allegro for additional packing options.



<sup>&</sup>lt;sup>2</sup>Variant not intended for automotive applications.

# High Accuracy, Galvanically Isolated Current Sensor IC With Small Footprint SOIC8 Package

### **SPECIFICATIONS**

### **Absolute Maximum Ratings**

Characteristic	Symbol	Notes	Rating	Units
Supply Voltage	V <sub>CC</sub>		6	V
Reverse Supply Voltage	V <sub>RCC</sub>		-0.1	V
Output Voltage	V <sub>IOUT</sub>		25	V
Reverse Output Voltage	V <sub>RIOUT</sub>		-0.1	V
Operating Ambient Temperature	T <sub>A</sub>	Range L	-40 to 150	°C
Junction Temperature	T <sub>J</sub> (max)		165	°C
Storage Temperature	T <sub>stg</sub>		-65 to 165	°C

#### **Isolation Characteristics**

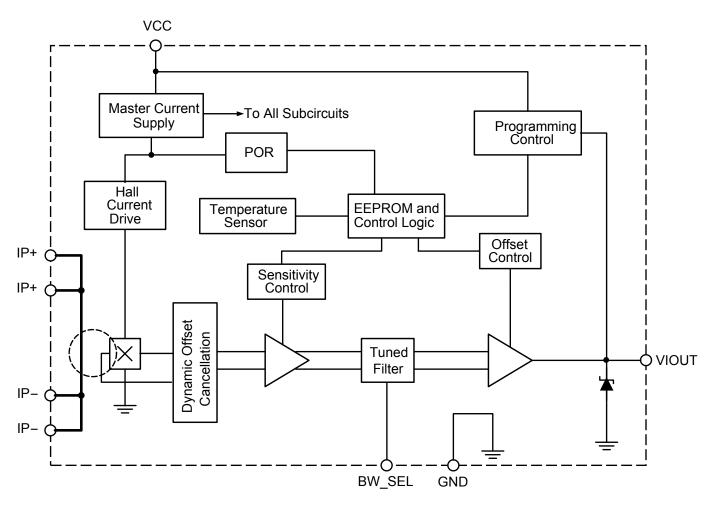
Characteristic	Symbol	Notes	Rating	Unit
Dielectric Strength Test Voltage	V <sub>ISO</sub>	Agency type-tested for 60 seconds per UL 60950-1 (edition. 2). Production tested at V <sub>ISO</sub> for 1 second, in accordance with UL 60950-1 (edition. 2).	2400	V <sub>RMS</sub>
Working Voltage for Basic Isolation	V	Maximum approved working voltage for basic (single)	420	V <sub>PK or</sub> VDC
Working Voltage for Basic Isolation	$V_{WVBI}$	isolation according UL 60950-1 (edition 2).	297	V <sub>RMS</sub>
Clearance	D <sub>cl</sub>	Minimum distance through air from IP leads to signal leads.	3.9	mm
Creepage	D <sub>cr</sub>	Minimum distance along package body from IP leads to signal leads.	3.9	mm

### **Thermal Characteristics**

Characteristic	Symbol	Test Conditions*	Value	Units
Package Thermal Resistance (Junction to Ambient)	$R_{\theta JA}$	Mounted on the Allegro 85-xxxx evaluation board with 1500 mm² of 2 oz. copper on each side, connected to pins 1 and 2, and to pins 3 and 4, with thermal vias connecting the layers. Performance values include the power consumed by the PCB.	23	°C/W
Package Thermal Resistance (Junction to Lead)	$R_{ heta JL}$	Mounted on the Allegro ASEK 722 evaluation board.	5	°C/W

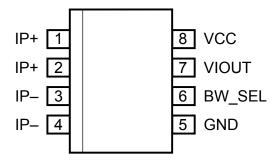
<sup>\*</sup>Additional thermal information available on the Allegro website.





**Functional Block Diagram** 

### **Pin-out Diagram and Terminal List**



**Pin-out Diagram** 

### **Terminal List Table**

Number	Name	Description
1, 2	IP+	Terminals for current being sensed; fused internally
3, 4	IP-	Terminals for current being sensed; fused internally
5	GND	Signal ground terminal
6	BW_SEL	Terminal for selecting 20 kHz or 80 kHz bandwidth
7	VIOUT	Analog output signal
8	VCC	Device power supply terminal

# High Accuracy, Galvanically Isolated Current Sensor IC With Small Footprint SOIC8 Package

## COMMON ELECTRICAL CHARACTERISTICS<sup>1</sup>: valid through the full range of $T_A = -40$ °C to 150°C, and at $V_{CC} = 3.3 \text{ V}$ ; unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Supply Voltage	V <sub>CC</sub>		3	3.3	3.6	V
Supply Current	I <sub>CC</sub>	V <sub>CC</sub> within V <sub>CC</sub> (min) and V <sub>CC</sub> (max)	_	9	12	mA
Output Capacitance Load	C <sub>L</sub>	VIOUT to GND	_	_	10	nF
Output Resistive Load	R <sub>L</sub>	VIOUT to GND	4.7	_	_	kΩ
Primary Conductor Resistance	R <sub>IP</sub>	T <sub>A</sub> = 25°C	_	0.65	_	mΩ
Rise Time		I <sub>P</sub> = I <sub>P</sub> (max), T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF, BW_SEL tied to GND	-	4	_	μs
Rise Time	t <sub>r</sub>	I <sub>P</sub> = I <sub>P</sub> (max), T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF, BW_SEL tied to VCC	_	17.5	_	μs
Propagation Delay		I <sub>P</sub> = I <sub>P</sub> (max), T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF, BW_SEL tied to GND	_	1	_	μs
FTOpagation Delay	t <sub>pd</sub>	I <sub>P</sub> = I <sub>P</sub> (max), T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF, BW_SEL tied to VCC	_	5	_	μs
Response Time	t <sub>RESPONSE</sub>	$I_P = I_P(max)$ , $T_A = 25$ °C, $C_L = 1$ nF, BW_SEL tied to GND	_	5	_	μs
Response Time		I <sub>P</sub> = I <sub>P</sub> (max), T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF, BW_SEL tied to VCC	_	22.5	_	μs
Internal Bandwidth	BWi	Small signal –3 dB; C <sub>L</sub> = 1 nF, BW_SEL tied to GND	_	80	_	kHz
internal bandwidth	DVVI	Small signal –3 dB; C <sub>L</sub> = 1nF, BW_SEL tied to VCC	_	20	_	kHz
Noise Density	I <sub>ND</sub>	Input referenced noise density; T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF	_	150	_	μA <sub>(rms)</sub> / √Hz
Noise		Input referenced noise; BWi = 80 kHz, T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF	_	42	_	mA <sub>(rms)</sub>
Noise	I <sub>N</sub>	Input referenced noise; BWi = 20 kHz, T <sub>A</sub> = 25°C, C <sub>L</sub> = 1 nF	_	21	_	mA <sub>(rms)</sub>
Nonlinearity	E <sub>LIN</sub>	Through full range of I <sub>P</sub>	_	±1		%
Saturation Voltage <sup>2</sup>	V <sub>OH</sub>	$R_L = 4.7 \text{ k}\Omega, T_A = 25^{\circ}\text{C}$	V <sub>CC</sub> - 0.33	_	_	V
	V <sub>OL</sub>	$R_L = 4.7 \text{ k}\Omega, T_A = 25^{\circ}\text{C}$	_	_	0.33	V
Power-On Time	t <sub>PO</sub>	Output reaches 90% of steady-state level, T <sub>A</sub> = 25°C, I <sub>P</sub> = I <sub>PR</sub> (max) applied	_	64	_	μs

<sup>&</sup>lt;sup>1</sup>Device may be operated at higher primary current levels,  $I_p$ , ambient temperatures,  $T_A$ , and internal leadframe temperatures, provided the Maximum Junction Temperature,  $T_J(max)$ , is not exceeded.



<sup>&</sup>lt;sup>2</sup>The sensor IC will continue to respond to current beyond the range of I<sub>P</sub> until the high or low saturation voltage; however, the nonlinearity in this region will be worse than through the rest of the measurement range.

# High Accuracy, Galvanically Isolated Current Sensor IC With Small Footprint SOIC8 Package

## xLLCTR-5AB PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance						
Current Sensing Range	I <sub>PR</sub>		-5	_	5	Α
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	264	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Bidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.5	_	V
Accuracy Performance						•
OWidt Fare	E <sub>sens</sub>	$T_A = 25^{\circ}\text{C}$ to 150°C; measured at $I_P = I_{PR}(\text{max})$	-2	_	2	%
Sensitivity Error		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2.5	_	%
Officet Voltage	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-15	-	15	mV
Offset Voltage		I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±20	_	mV
Total Outrout France*	_	$I_P = I_{PR}(max), T_A = 25^{\circ}C \text{ to } 150^{\circ}C$	-2.5	-	2.5	%
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max), T_A = -40^{\circ}C \text{ to } 25^{\circ}C$	_	±3	_	%
Lifetime Drift Characteristics						•
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		_	±2	_	%

<sup>\*</sup>Percentage of  $I_P$ , with  $I_P = I_{PR}(max)$ 



## xLLCTR-10AU PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance						
Current Sensing Range	I <sub>PR</sub>		0	_	10	Α
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	264	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Unidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.1	-	V
Accuracy Performance						
O Ministry France	E <sub>sens</sub>	$T_A = 25$ °C to 150°C; measured at $I_P = I_{PR}(max)$	-2	_	2	%
Sensitivity Error		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2.5	_	%
Offeet Veltere	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-15	_	15	mV
Offset Voltage		I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±20	_	mV
Total Outside Forest	_	$I_P = I_{PR}(max)$ , $T_A = 25^{\circ}C$ to $150^{\circ}C$	-2.5	-	2.5	%
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max)$ , $T_A = -40$ °C to 25°C	_	±3	_	%
Lifetime Drift Characteristics						
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		-	±2	_	%

<sup>\*</sup>Percentage of  $I_p$ , with  $I_p = I_{pR}(max)$ 

## xLLCTR-10AB PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance						
Current Sensing Range	I <sub>PR</sub>		-10	_	10	А
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	132	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Bidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.5	_	V
Accuracy Performance						
Concitivity From	E <sub>sens</sub>	$T_A = 25^{\circ}\text{C}$ to 150°C; measured at $I_P = I_{PR}(\text{max})$	-1.5	_	1.5	%
Sensitivity Error		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2	_	%
Office A Vallage	.,	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-10	_	10	mV
Offset Voltage	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±15	_	mV
Tabal Outside Face of	_	$I_P = I_{PR}(max), T_A = 25^{\circ}C \text{ to } 150^{\circ}C$	-2	_	2	%
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max), T_A = -40^{\circ}C \text{ to } 25^{\circ}C$	_	±3	_	%
Lifetime Drift Characteristics						
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		-	±2	_	%

<sup>\*</sup>Percentage of  $I_P$ , with  $I_P = I_{PR}(max)$ 



## xLLCTR-20AU PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance	,					
Current Sensing Range	I <sub>PR</sub>		0	_	20	Α
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	132	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Unidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.1	-	V
Accuracy Performance						
0 "" " =	E <sub>sens</sub>	$T_A = 25$ °C to 150°C; measured at $I_P = I_{PR}(max)$	-1.5	_	1.5	%
Sensitivity Error		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2	_	%
Officet Voltage	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-10	-	10	mV
Offset Voltage		I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±15	_	mV
Total Outrout France*	_	$I_{P} = I_{PR}(max), T_{A} = 25^{\circ}C \text{ to } 150^{\circ}C$	-2	_	2	%
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max), T_A = -40^{\circ}C \text{ to } 25^{\circ}C$	_	±3	_	%
Lifetime Drift Characteristics						
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		-	±2	_	%

<sup>\*</sup>Percentage of  $I_P$ , with  $I_P = I_{PR}(max)$ 

## xLLCTR-20AB PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance						-
Current Sensing Range	I <sub>PR</sub>		-20	_	20	А
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	66	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Bidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.5	-	V
Accuracy Performance						
Canaitivity Error	E <sub>sens</sub>	$T_A = 25^{\circ}\text{C}$ to 150°C; measured at $I_P = I_{PR}(\text{max})$	-1.5	_	1.5	%
Sensitivity Error		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2	_	%
Office to Valtage	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-10	_	10	mV
Offset Voltage		I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±15	_	mV
Total Ovitavit Francis	_	$I_P = I_{PR}(max), T_A = 25^{\circ}C \text{ to } 150^{\circ}C$	-2	_	2	%
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max)$ , $T_A = -40^{\circ}C$ to 25°C	_	±3	_	%
Lifetime Drift Characteristics						
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		_	±2	-	%

<sup>\*</sup>Percentage of  $I_P$ , with  $I_P = I_{PR}(max)$ 



## xLLCTR-40AU PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance						
Current Sensing Range	I <sub>PR</sub>		0	_	40	Α
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	66	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Unidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.1	-	V
Accuracy Performance						
0 "" " =	E <sub>sens</sub>	$T_A = 25$ °C to 150°C; measured at $I_P = I_{PR}(max)$	-1.5	_	1.5	%
Sensitivity Error		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2	_	%
Officet Voltage	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-10	-	10	mV
Offset Voltage		I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±15	_	mV
Total Outrout France*	_	$I_P = I_{PR}(max)$ , $T_A = 25^{\circ}C$ to $150^{\circ}C$	-2	_	2	%
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max), T_A = -40^{\circ}C \text{ to } 25^{\circ}C$	_	±3	_	%
Lifetime Drift Characteristics						
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		_	±2	_	%

<sup>\*</sup>Percentage of  $I_P$ , with  $I_P = I_{PR}(max)$ 

## xLLCTR-40AB PERFORMANCE CHARACTERISTICS: $T_A$ Range L, valid at $T_A$ = -40°C to 150°C, $V_{CC}$ = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Nominal Performance						
Current Sensing Range	I <sub>PR</sub>		-40	_	40	А
Sensitivity	Sens	$I_{PR}(min) < I_{P} < I_{PR}(max)$	_	33	_	mV/A
Zero Current Output Voltage	V <sub>IOUT(Q)</sub>	Bidirectional; I <sub>P</sub> = 0 A	_	V <sub>CC</sub> x 0.5	-	V
Accuracy Performance						
Sensitivity Error	E <sub>sens</sub>	$T_A = 25^{\circ}\text{C}$ to 150°C; measured at $I_P = I_{PR}(\text{max})$	-1.5	_	1.5	%
		$T_A = -40$ °C to 25°C; ; measured at $I_P = I_{PR}(max)$	_	±2	_	%
Offset Voltage	V <sub>OE</sub>	I <sub>P</sub> = 0 A; T <sub>A</sub> = 25°C to 150°C	-10	_	10	mV
		I <sub>P</sub> = 0 A; T <sub>A</sub> = -40°C to 25°C	_	±15	_	mV
Total Output Error*	E <sub>TOT</sub>	$I_P = I_{PR}(max), T_A = 25^{\circ}C \text{ to } 150^{\circ}C$	-2	_	2	%
		$I_P = I_{PR}(max)$ , $T_A = -40^{\circ}C$ to 25°C	_	±3	_	%
Lifetime Drift Characteristics						
Sensitivity Error Lifetime Drift	E <sub>sens_drift</sub>		_	±2	_	%
Total Output Error Lifetime Drift	E <sub>tot_drift</sub>		_	±2	-	%

<sup>\*</sup>Percentage of  $I_P$ , with  $I_P = I_{PR}(max)$ 



### **DEFINITIONS OF ACCURACY CHARACTERISTICS**

**Sensitivity (Sens).** The change in sensor IC output in response to a 1A change through the primary conductor. The sensitivity is the product of the magnetic circuit sensitivity (G/A) (1 G = 0.1 mT) and the linear IC amplifier gain (mV/G). The linear IC amplifier gain is programmed at the factory to optimize the sensitivity (mV/A) for the full-scale current of the device.

**Nonlinearity (E**<sub>LIN</sub>). The nonlinearity is a measure of how linear the output of the sensor IC is over the full current measurement range. The nonlinearity is calculated as:

$$E_{LIN} = \left\{ 1 - \left[ \frac{V_{IOUT}(I_{PR}(\text{max})) - V_{IOUT(Q)}}{2 \times V_{IOUT}(I_{PR}(\text{max})/2) - V_{IOUT(Q)}} \right] \right\} \times 100 \text{ (\%)}$$

where  $V_{IOUT}(I_{PR}(max))$  is the output of the sensor IC with the maximum measurement current flowing through it and  $V_{IOUT}(I_{PR}(max)/2)$  is the output of the sensor IC with half of the maximum measurement current flowing through it.

**Zero Current Output Voltage (V**<sub>IOUT(Q)</sub>). The output of the sensor when the primary current is zero. For a unipolar supply voltage, it nominally remains at  $0.5 \times V_{CC}$  for a bidirectional device and  $0.1 \times V_{CC}$  for a unidirectional device. For example, in the case of a bidirectional output device,  $V_{CC} = 3.3$  V translates into  $V_{IOUT(Q)} = 1.65$  V. Variation in  $V_{IOUT(Q)}$  can be attributed to the resolution of the Allegro linear IC quiescent voltage trim and thermal drift.

**Offset Voltage (V<sub>OE</sub>).** The deviation of the device output from its ideal quiescent value of  $0.5 \times V_{CC}$  (bidirectional) or  $0.1 \times V_{CC}$  (unidirectional) due to nonmagnetic causes. To convert this voltage to amperes, divide by the device sensitivity, Sens.

**Total Output Error** ( $E_{TOT}$ ). The difference between the current measurement from the sensor IC and the actual current ( $I_p$ ), relative to the actual current. This is equivalent to the difference between the ideal output voltage and the actual output voltage, divided by the ideal sensitivity, relative to the current flowing through the primary conduction path:

$$E_{\text{TOT}}(I_{\text{P}}) = \frac{V_{\text{IOUT\_ideal}}(I_{\text{P}}) - V_{\text{IOUT}}(I_{\text{P}})}{\text{Sens}_{\text{ideal}}(I_{\text{P}}) \times I_{\text{P}}} \times 100 \text{ (\%)}$$

The Total Output Error incorporates all sources of error and is a function of  $I_P$ . At relatively high currents,  $E_{TOT}$  will be mostly due to sensitivity error, and at relatively low currents,  $E_{TOT}$  will be mostly due to Offset Voltage ( $V_{\rm OE}$ ). In fact, at  $I_P=0$ ,  $E_{TOT}$  approaches infinity due to the offset. This is illustrated in Figures 1 and 2. Figure 1 shows a distribution of output voltages versus  $I_P$  at 25°C and across temperature. Figure 2 shows the corresponding  $E_{TOT}$  versus  $I_P$ .

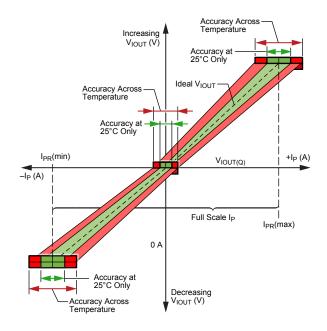


Figure 1: Output Voltage versus Sensed Current

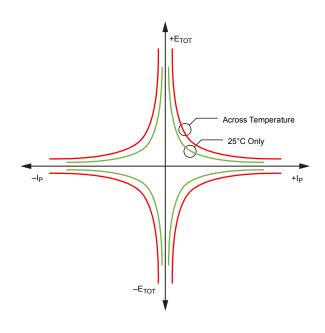


Figure 2: Total Output Error versus Sensed Current



### **DEFINITIONS OF DYNAMIC RESPONSE CHARACTERISTICS**

**Power-On Time (t<sub>PO</sub>).** When the supply is ramped to its operating voltage, the device requires a finite time to power its internal components before responding to an input magnetic field. Power-On Time,  $t_{PO}$ , is defined as the time it takes for the output voltage to settle within  $\pm 10\%$  of its steady state value under an applied magnetic field, after the power supply has reached its minimum specified operating voltage,  $V_{CC}(min)$ , as shown in the chart at right.

**Rise Time (t<sub>r</sub>).** The time interval between a) when the sensor IC reaches 10% of its full scale value, and b) when it reaches 90% of its full scale value. The rise time to a step response is used to derive the bandwidth of the current sensor IC, in which  $f(-3 \text{ dB}) = 0.35/t_r$ . Both  $t_r$  and  $t_{RESPONSE}$  are detrimentally affected by eddy current losses observed in the conductive IC ground plane.

**Propagation Delay**  $(t_{pd})$ . The propagation delay is measured as the time interval a) when the primary current signal reaches 20% of its final value, and b) when the device reaches 20% of its output corresponding to the applied current.

**Response Time** ( $t_{RESPONSE}$ ). The time interval between a) when the primary current signal reaches 90% of its final value, and b) when the device reaches 90% of its output corresponding to the applied current.

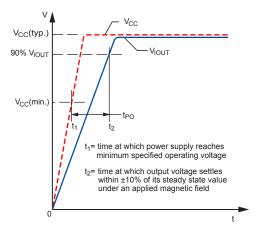


Figure 3: Power-On Time (t<sub>PO</sub>)

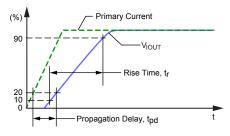


Figure 4: Rise Time (t<sub>r</sub>) and Propagation Delay (t<sub>pd</sub>)

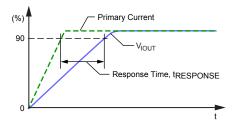


Figure 5: Response Time (t<sub>RESPONSE</sub>)



### **Package Outline Drawing**

For Reference Only – Not for Tooling Use
(Reference MS-012AA)
Dimensions in millimeters – NOT TO SCALE Dimensions exclusive of mold flash, gate burrs, and dambar protrusions Exact case and lead configuration at supplier discretion within limits shown

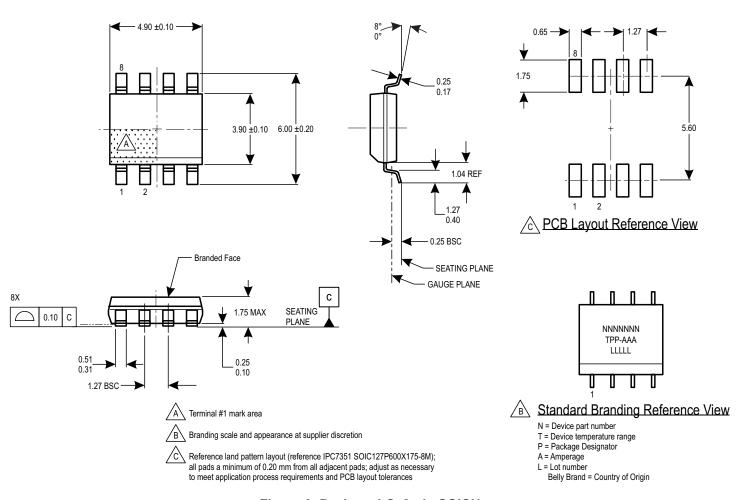


Figure 6: Package LC, 8-pin SOICN

# High Accuracy, Galvanically Isolated Current Sensor IC With Small Footprint SOIC8 Package

#### **Revision History**

Revision	Revision Date	Description of Revision
_	June 10, 2014	Initial release.

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